

Application/Control No.	Applicant(s)/Patent under Reexamination
10/685,807	HIROSHIMA ET AL.
Examiner	Art Unit
John B. Nguyen	2819

SEARCHED					
Class	Subclass	Date	Examiner		
333	134,202	7/7/2005	, NC		
	206,222				
333	208,135	7/7/2005	JN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
text search updated	7/7/2005	ИС	